Gagik A Oganesyan

List of Publications by Year in descending order

Source: https://exaly.com/author-pdf/1010651/publications.pdf

Version: 2024-02-01

759233 940533 78 436 12 16 citations h-index g-index papers 78 78 78 340 docs citations times ranked citing authors all docs

#	Article	IF	CITATIONS
1	Similarities and distinctions of defect production by fast electron and proton irradiation: Moderately doped silicon and silicon carbide of n-type. Semiconductors, 2012, 46, 456-465.	0.5	31
2	Radiation-induced defects in n-type GaN and InN. Physica B: Condensed Matter, 2001, 308-310, 58-61.	2.7	25
3	Double thermal donors in Czochralski-grown silicon heat-treated under atmospheric and high hydrostatic pressures. Physica Status Solidi (B): Basic Research, 2003, 235, 75-78.	1.5	25
4	Highly doped p-type 3C–SiC on 6H–SiC substrates. Semiconductor Science and Technology, 2008, 23, 075004.	2.0	17
5	Positron annihilation on defects in silicon irradiated with 15 MeV protons. Journal of Physics Condensed Matter, 2013, 25, 035801.	1.8	17
6	The effect of germanium doping on the evolution of defects in silicon. Materials Science and Engineering B: Solid-State Materials for Advanced Technology, 2008, 154-155, 133-136.	3.5	16
7	Effect of electron irradiation on carrier removal rate in silicon and silicon carbide with 4H modification. Semiconductors, 2008, 42, 242-247.	0.5	16
8	Charge carrier removal rates in n-type silicon and silicon carbide subjected to electron and proton irradiation. Physica B: Condensed Matter, 2009, 404, 4752-4754.	2.7	16
9	Low-temperature photoluminescence characterization of defects formation in hydrogen and helium implanted silicon at post-implantation annealing. Physica B: Condensed Matter, 2001, 308-310, 181-184.	2.7	15
10	Spin-dependent transport of holes in silicon quantum wells confined by superconductor barriers. Physica C: Superconductivity and Its Applications, 2008, 468, 840-843.	1.2	15
11	Influence of the defect density (twins boundaries) on electrical parameters of 3C-SiC epitaxial films. Physica B: Condensed Matter, 2009, 404, 4758-4760.	2.7	13
12	EPR/ENDOR Investigation on the Nature of Heat Treatment Centers in Silicon. Materials Science Forum, 1994, 143-147, 141-146.	0.3	12
13	Formation of deep thermal donors in heatâ€treated Czochralski silicon. Applied Physics Letters, 1996, 68, 2375-2377.	3.3	12
14	IR studies of oxygen–vacancy defects in electron-irradiated Ge-doped Si. Physica B: Condensed Matter, 2007, 401-402, 487-490.	2.7	12
15	Effects of germanium doping on the behavior of oxygen and carbon impurities and impurity-related complexes in Si. Physica B: Condensed Matter, 2009, 404, 4693-4697.	2.7	12
16	Vacancy-donor pairs and their formation in irradiated n-Si. Semiconductors, 2014, 48, 1438-1443.	0.5	12
17	Formation and annealing of vacancy-P complexes in proton-irradiated germanium. Acta Materialia, 2015, 100, 1-10.	7.9	11
18	Monovacancy–As complexes in proton-irradiated Ge studied by positron lifetime spectroscopy. Acta Materialia, 2015, 83, 473-478.	7.9	10

#	Article	IF	Citations
19	Comparative study of changes in electrical properties of silicon and silicon carbide upon proton irradiation. Semiconductors, 2010, 44, 678-684.	0.5	9
20	Stress-induced changes of thermal donor formation in heat-treated Czochralski-grown silicon. Physica B: Condensed Matter, 2003, 340-342, 769-772.	2.7	8
21	Some challenging points in the identification of defects in floating-zone n-type silicon irradiated with 8 and 15 MeV protons. Semiconductors, 2016, 50, 1291-1298.	0.5	8
22	New Donors in Heat-Treated Cz-Si, Their Components and Formation Kinetics. Solid State Phenomena, 1995, 47-48, 259-266.	0.3	7
23	Title is missing!. Journal of Materials Science: Materials in Electronics, 2001, 12, 223-225.	2.2	7
24	Effect of the energy of recoil atoms on conductivity compensation in moderately doped n-Si and n-SiC under irradiation with MeV electrons and protons. Nuclear Instruments & Methods in Physics Research B, 2016, 384, 100-105.	1.4	7
25	Oxygen agglomeration and formation of oxygen-related thermal donors in heat-treated silicon. Crystal Research and Technology, 2003, 38, 394-398.	1.3	6
26	Radiation-produced defects in n-GaN. Physica B: Condensed Matter, 2007, 401-402, 315-318.	2.7	6
27	Metal-insulator transition in n-3C-SiC epitaxial films. Journal of Applied Physics, 2009, 105, 023706.	2.5	6
28	The relationship between the reliability of transistors with 2D AlGaN/GaN channel and organization type of nanomaterial. Technical Physics Letters, 2016, 42, 701-703.	0.7	6
29	Shallow donors in silicon coimplanted with rare-earth ions and oxygen. Physica B: Condensed Matter, 2001, 308-310, 350-353.	2.7	5
30	Shallow donor centers in gallium nitrides. Physica Status Solidi C: Current Topics in Solid State Physics, 2003, 0, 601-604.	0.8	5
31	On the nature and structures of different heat treatment centres in n- and p-type silicon. Semiconductor Science and Technology, 1994, 9, 1346-1353.	2.0	4
32	Quantum supercurrent and Andreev reflection in silicon nanostructures. Semiconductors, 2009, 43, 1455-1465.	0.5	4
33	Electrical characteristics of multigraphene films grown on high-resistivity silicon carbide substrates. Semiconductors, 2010, 44, 1389-1391.	0.5	4
34	Positron Probing of Vacancy Volume of Thermally Stable Deep Donors Produced with 15 MeV Protons in <i>n</i> -FZ-Si:P Crystals. Solid State Phenomena, 0, 205-206, 317-322.	0.3	4
35	<title>Peculiarities of the thermal donor formation in Czochralski-grown silicon under high hydrostatic pressure</title> ., 2001, , .		3
36	Investigation of vacancy-type complexes in GaN and AlN using positron annihilation. Semiconductors, 2002, 36, 1106-1110.	0.5	3

3

#	Article	IF	CITATIONS
37	The Production of Vacancy-Oxygen Defects in Electron-Irradiated Cz-Si Initially Treated at High Temperatures and High Pressures. Solid State Phenomena, 2009, 156-158, 123-128.	0.3	3
38	Cascade phonon-assisted trapping of positrons by divacancies in n-FZ-Si(P) single crystals irradiated with 15 MeV protons. AIP Conference Proceedings, 2014, , .	0.4	3
39	Electrical properties of diluted n- and p-Si1 â^' x Ge x at small x. Semiconductors, 2014, 48, 1552-1556.	0.5	3
40	Positron annihilation lifetime in float-zone n-type silicon irradiated by fast electrons: a thermally stable vacancy defect. Physica Status Solidi C: Current Topics in Solid State Physics, 2016, 13, 807-811.	0.8	3
41	Radiation-produced defects in germanium: Experimental data and models of defects. Semiconductors, 2017, 51, 1571-1587.	0.5	3
42	Electron- and proton irradiation of strongly doped silicon of p-type: Formation and annealing of boron-related defects. Journal of Applied Physics, 2022, 131, 125705.	2.5	3
43	Thermal Donors in Silicon Implanted with Rare Earth Impurities. Solid State Phenomena, 2001, 82-84, 93-98.	0.3	2
44	Features of the formation of thermal donors in silicon under elastic tensile stress. Journal of Surface Investigation, 2007, 1, 294-297.	0.5	2
45	Galvanomagnetic properties of 3C-SiC epilayers grown on hexagonal SiC substrates. Technical Physics Letters, 2007, 33, 1035-1037.	0.7	2
46	Formation rate of vacancy–oxygen complexes in heat-treated Czochralski grown silicon under gamma-irradiation. Journal of Materials Science: Materials in Electronics, 2007, 18, 701-704.	2.2	2
47	Negative magnetoresistance in SiC heteropolytype junctions. Journal of Materials Science: Materials in Electronics, 2008, 19, 793-796.	2.2	2
48	Electrical properties of thermal donors formed in silicon under elastic tensile stress. Journal of Surface Investigation, 2009, 3, 962-965.	0.5	2
49	Conductivity compensation in p-6H-SiC in irradiation with 8-MeV protons. Semiconductors, 2011, 45, 1145-1147.	0.5	2
50	Positron Lifetime at Deep Donors of Radiation Origin in Proton - Irradiated FZ-Silicon Single Crystals. Materials Science Forum, 0, 733, 224-227.	0.3	2
51	Similarity of Atomic Configurations of Thermally Stable Positron-Sensitive Complexes Produced with 0.9-MeV Electrons and 15-MeV Protons in <i>n–</i> FZ <i>–</i> Si:P Crystals. Solid State Phenomena, 0, 242, 296-301.	0.3	2
52	Specific features of proton interaction with transistor structures having a 2D AlGaN/GaN channel. Technical Physics Letters, 2016, 42, 1079-1082.	0.7	2
53	Peculiarities in the Defect Behavior in Heat-Treated Cz-Si with a Low and High Oxygen Content. Solid State Phenomena, 1993, 32-33, 173-180.	0.3	1
54	Photoluminescence characterization of thermal defects in Czochralski grown silicon heat treated at 600°C. Physica B: Condensed Matter, 2003, 340-342, 1018-1021.	2.7	1

#	Article	IF	CITATIONS
55	"New Donors" in Czochralski Grown Silicon Annealed at T≥ 600°C under Compressive Stress. Solid State Phenomena, 2005, 108-109, 181-186.	0.3	1
56	Reverse recovery of Si/Si1 \hat{a}^{γ} x Ge x heterodiodes fabricated by direct bonding. Technical Physics Letters, 2011, 37, 632-635.	0.7	1
57	Positron Probing of Point Radiation Defects in Proton - Irradiated FZ-Silicon Single Crystals. Solid State Phenomena, 0, 178-179, 313-318.	0.3	1
58	Production and Annealing of Defects in Proton-Irradiated n-Ge. Solid State Phenomena, 0, 205-206, 422-426.	0.3	1
59	Donor-vacancy pairs in irradiated n-Ge: A searching look at the problem. , 2014, , .		1
60	Positron probing of phosphorus-vacancy complexes in silicon irradiated with 15 MeV protons. Journal of Physics: Conference Series, 2015, 618, 012013.	0.4	1
61	Positron probing of open vacancy volume of phosphorusâ€vacancy complexes in floatâ€zone nâ€type silicon irradiated by 0.9â€MeV electrons and by 15â€MeV protons. Physica Status Solidi C: Current Topics in Solid State Physics, 2017, 14, 1700120.	0.8	1
62	Impact of Compressive Stress on the Formation of Thermal Donors in Heat-Treated Silicon. Solid State Phenomena, 2002, 82-84, 259-266.	0.3	0
63	Galvanomagnetic Properties of 3C-SiC/6H-SiC Heterostructures. Materials Science Forum, 0, 600-603, 541-544.	0.3	0
64	Investigation of the Metal–Insulator Transition in n-3C-SiC Epitaxial Films. Materials Science Forum, 0, 615-617, 335-338.	0.3	0
65	P-Type 3C-SiC Grown by Sublimation Epitaxy on 6H-SiC Substrates. Materials Science Forum, 0, 615-617, 177-180.	0.3	0
66	Electrically active defects in erbium-implanted silicon: Effects of annealing under high hydrostatic pressures and electron irradiation. Materials Science and Engineering B: Solid-State Materials for Advanced Technology, 2009, 159-160, 157-159.	3 . 5	0
67	Metal-insulator transition in n-3C-SiC epitaxial films. Semiconductors, 2009, 43, 318-322.	0.5	0
68	Low Temperature near Band Gap Photoluminescence of 3C-SiC/15R-SiC and 3C-SiC/6H-SiC Heterostructures. Materials Science Forum, 0, 645-648, 259-262.	0.3	0
69	Electron Mobility in Moderately Doped Si _{1-x} Ge _x . Solid State Phenomena, 0, 178-179, 31-34.	0.3	0
70	P-6H-SiC Conductivity Compensation after Irradiation of 8MeV Protons. Materials Science Forum, 2013, 740-742, 353-356.	0.3	0
71	Electrical Properties of Defects in Ga-Doped Ge Irradiated with Fast Electrons and Protons. Solid State Phenomena, 0, 242, 316-321.	0.3	0
72	Effect of irradiation with 15-MeV protons on the compensation of GeâŒ@Sb〉 conductivity. Journal of Surface Investigation, 2017, 11, 601-605.	0.5	0

#	Article	lF	CITATIONS
73	Effects of irradiation with 8-MeV protons on n-3C-SiC heteroepitaxial layers. Semiconductors, 2017, 51, 1044-1046.	0.5	O
74	Interaction Rates of Group-III and Group-V Impurities with Intrinsic Point Defects in Irradiated Si and Ge. Semiconductors, 2018, 52, 1677-1685.	0.5	0
75	Towards the Modeling of Impurity-Related Defects in Irradiated n-Type Germanium: a Challenge to Theory. Semiconductors, 2020, 54, 1388-1394.	0.5	O
76	Vacancy-Phosphorus Complexes in Electron-Irradiated Floating-Zone n-Type Silicon: New Points in Annealing Studies. Semiconductors, 2020, 54, 46-54.	0.5	0
77	Microstructure of bismuth centers in silicon before and after irradiation with 15 MeV protons. Journal of Physics Condensed Matter, 2021, 33, 245702.	1.8	O
78	10.1007/s11453-008-2023-8., 2010, 42, 242.		0